

<b>Notice of References Cited</b>	Application/Control No. 10/665,083		Applicant(s)/Patent Under Reexamination WONG, MARVIN GLENN	
	Examiner Jason L. Lazorcik		Art Unit 1731	Page 1 of 2

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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	U	"Reusable Vice-Style SEM Sample Holders for Pin Mount Stages" - reprint by Michigan State University from Microscopy Today copyright 2001 - <a href="http://www.chems.msu.edu/curr.stud/mse.sops/vice.htm">http://www.chems.msu.edu/curr.stud/mse.sops/vice.htm</a>
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	W	Corning 1737 AMLCD Glass Substrates: Materials Information - <a href="http://www.vinkarola.com/pdf/Corning%20Glass%201737%20Properties.pdf">http://www.vinkarola.com/pdf/Corning%20Glass%201737%20Properties.pdf</a>
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